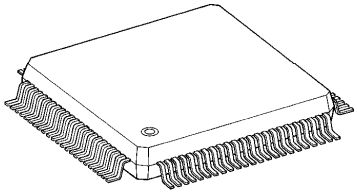
TOSHIBA CMOS DIGITAL INTEGRATED CIRCUIT SILICON MONOLITHIC

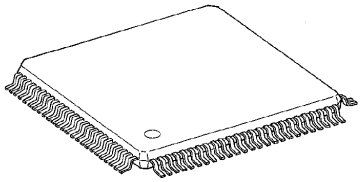
T6A40

ROW DRIVER FOR A DOT MATRIX LCD

The T6A40 is a 68-channel-output row driver for an STN dot matrix LCD. The T6A40 features −28 V LCD drive voltage. The T6A40 is able to drive LCD panels with a duty ratio of up to 1/240. It is recommended for use with the T6A39/T6A39A.



QFP92-P-1818-0.70B



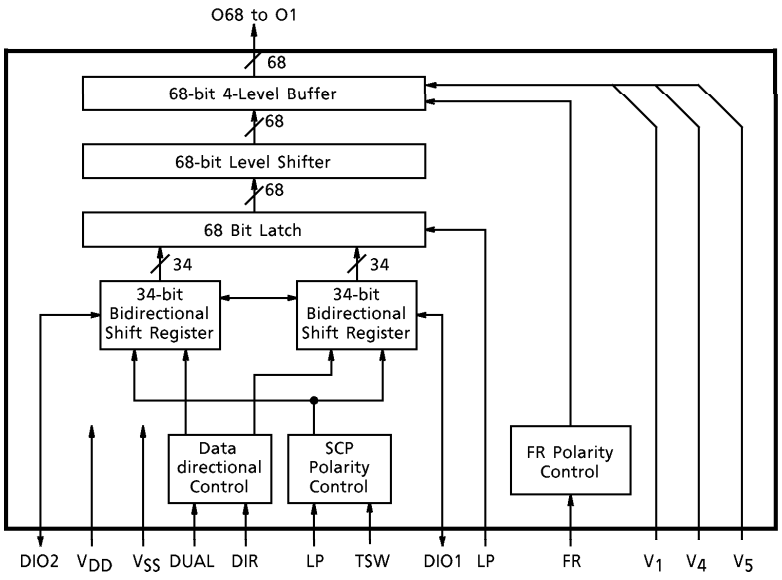
TQFP100-P-1414-0.50

Weight
QFP92-P-1818-0.70B : 1.45 g (Typ.)
TQFP100-P-1414-0.50 : 0.45 g (Typ.)

FEATURES

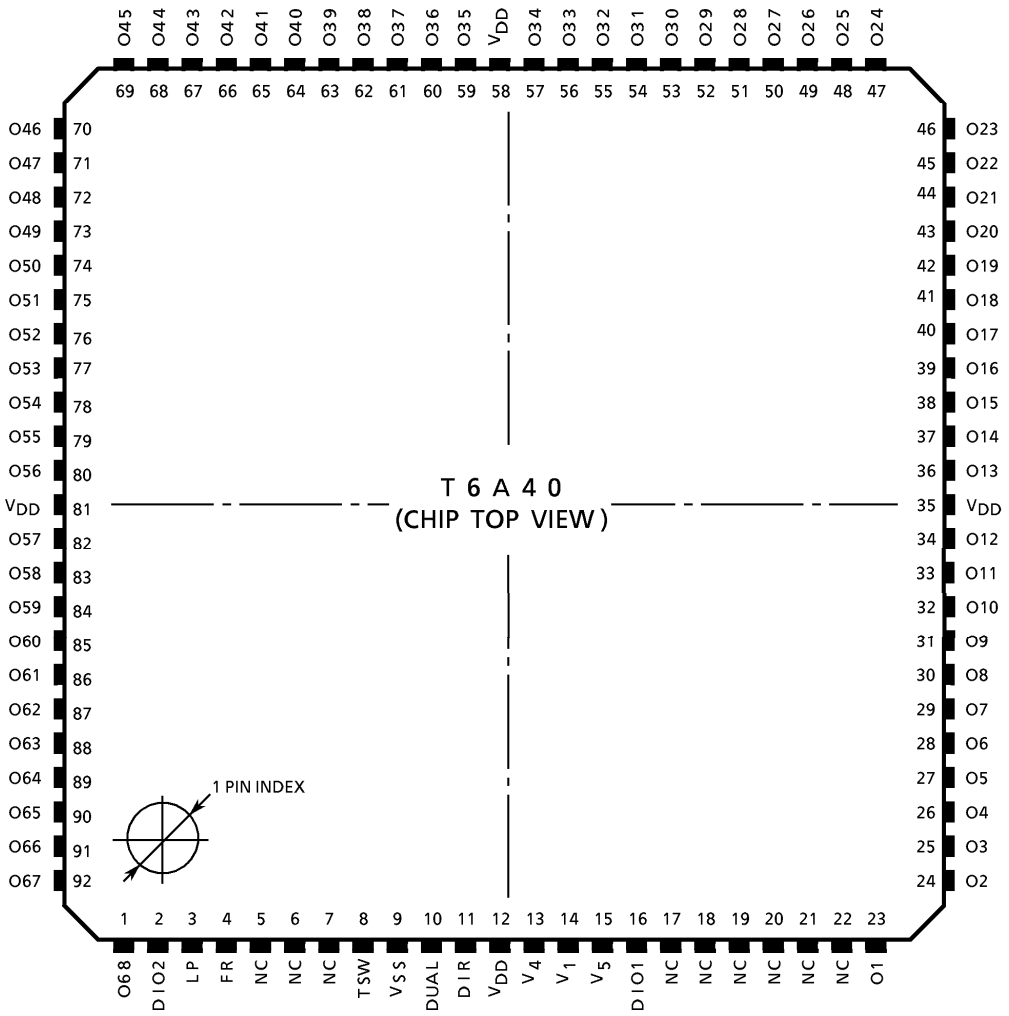
- Display duty application : to 1/240
- LCD drive signal : 68
- Data transfer : 1-bit bidirectional
  ① O68 ← O1
  ② O68 → O1
  ③ O1 → O34, O35 ← O68
- LCD drive voltage : −8 to −28 V (max −30 V)
- Operating voltage : 4.5 to 5.5 V
- Operating temperature : −20 to 75°C
- LCD drive output resistance : 1.5 kΩ (max) (12.8 V, 1/9 bias)
- LCD drive output timing : Change on falling edge of LP

BLOCK DIAGRAM

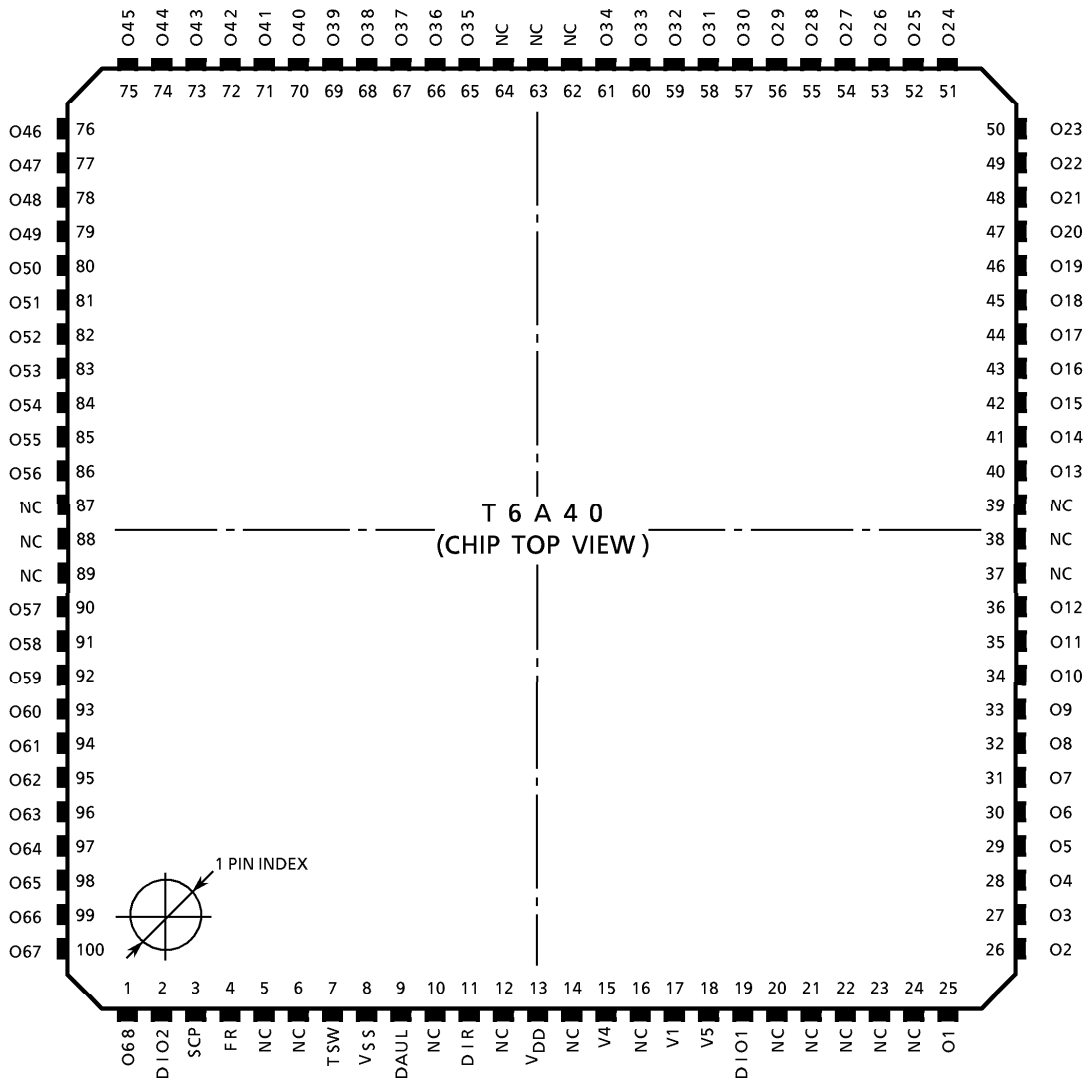


980910EBA2

PIN ASSIGNMENT
QFP92-P-1818-0.70B



PIN ASSIGNMENT
TQFP100-P-1414-0.50



PIN FUNCTIONS

PIN NAME	I/O	FUNCTIONS	LEVEL
O1 to O68	Output	Output for LCD drive signal	V_{DD} to V_5
DIO1, DIO2	I/O	Input/output for shift data	V_{DD} to V_{SS}
LP	Input	(Shift Clock Pulse) Input for shift clock pulse	
FR	Input	(Frame) Input for frame signal	
DUAL	Input	(Dual Mode) Terminal for dual input mode or single input mode select	
DIR	Input	(Direction) Input for data flow direction select	
TSW	Input	(Terminal Switch) When tied to V_{SS} : (O1 to O68) output on the rising edge of LP When tied to V_{DD} : (O1 to O68) output on the falling edge of LP	
V_{DD}	—	Power supply for internal logic (5 V)	—
V_{SS}	—	Power supply for internal logic (0 V)	
V_1	—	Power supply for LCD drive circuit	
V_4	—	Power supply for LCD drive circuit	
V_5	—	Power supply for LCD drive circuit	

RELATION BETWEEN FR, DATA INPUT AND OUTPUT LEVEL

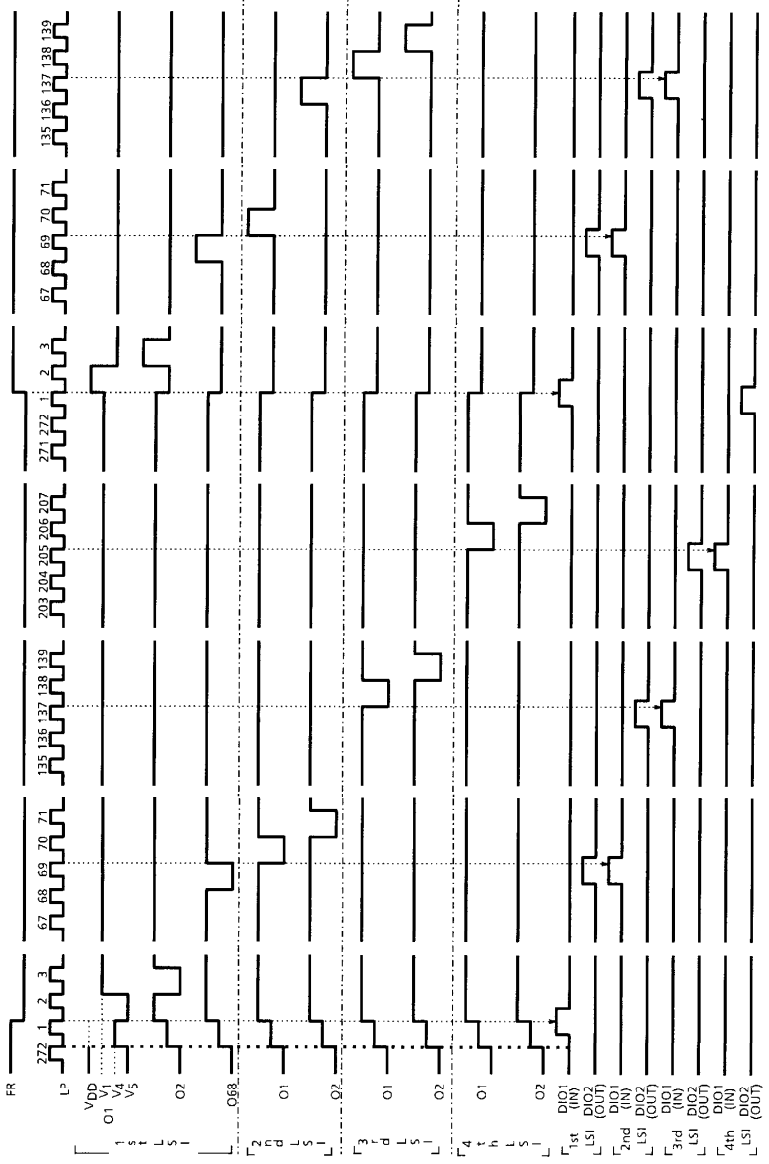
F R	DATA INPUT (DIO1, DIO2)	OUTPUT LEVEL
L	L	V_1
L	H	V_5
H	L	V_4
H	H	V_{DD}

DATA INPUT FORMAT

DUAL	DIR	DATA FLOW	DATA INPUT	
			DIO1	DIO2
V_{DD}	V_{DD}	O1 → O34	IN	IN
		O68 → O35		
V_{SS}	V_{DD}	O1 → O68	IN	OUT
V_{DD}	V_{SS}	O68 → O1	OUT	IN
V_{SS}	V_{SS}			

TIMING DIAGRAM

DIR = H, DUAL = L, TSW = H



T6A40−5

ABSOLUTE MAXIMUM RATINGS

(Ensure that the following conditions are maintained, $V_{DD} \geqq V_1 \geqq V_4 \geqq V_5$, V_{SS} = 0 V)

ITEM	SYMBOL	PIN NAME	RATING	UNIT
Supply Voltage 1	V_{DD}	V_{DD}	− 0.3 to 7.0	V
Supply Voltage 2	V_1	V_1	V_{DD} − 30.0 to V_{DD} + 0.3	V
Supply Voltage 3	V_4	V_4	V_{DD} − 30.0 to V_{DD} + 0.3	V
Supply Voltage 4	V_5	V_5	V_{DD} − 30.0 to V_{DD} + 0.3	V
Input Voltage	V_{IN}	(*1)	− 0.3 to V_{DD} + 0.3	V
Operating Temperature	T_{opr}	—	− 20 to 75	°C
Storage Temperature	T_{stg}	—	− 55 to 125	°C

(*1) : FR, DIR, DIO1, DIO2, DUAL, TSW, LP

ELECTRICAL CHARACTERISTICS

DC CHARACTERISTICS

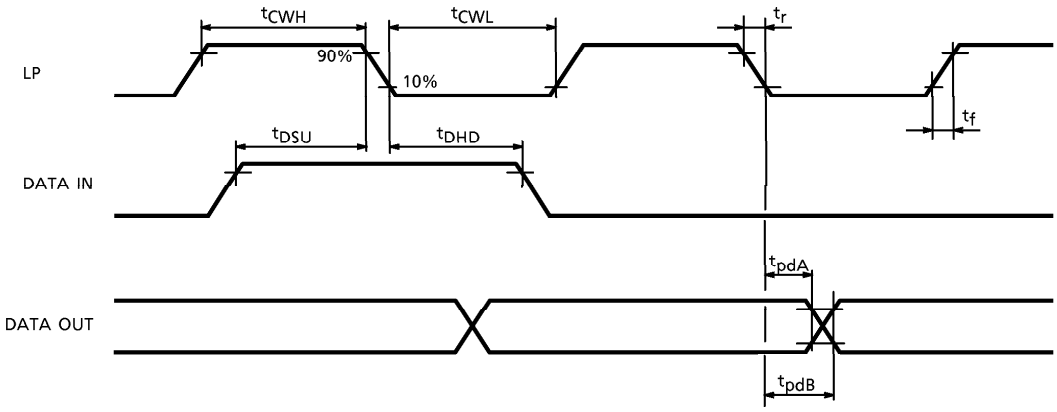
TEST CONDITIONS (Unless otherwise noted, V_{SS} = 0 V, V_{DD} = 4.5 V to 5.5 V, $V_5 = (V_{DD} - 23)$ V ± 10%, Ta = − 20 to 75°C)

ITEM		SYMBOL	TEST CIR-CUIT	TEST CONDITION	MIN	TYP.	MAX	UNIT	PIN NAME
Supply Voltage 1		V_{DD}	—	—	4.5	5.0	5.5	V	V_{DD}
Supply Voltage 2		V_5	—	—	V_{DD} − 28	—	V_{DD} − 8.0	V	V_5
Input Voltage	H Level	V_{IH}	—	(*2)	V_{DD} − 0.8	—	V_{DD}	V	FR, DIR, DIO1, DIO2, DUAL, LP, TSW
	L Level	V_{IL}		(*2)	0	—	0.8		
Output Voltage	H Level	V_{OH}	—	I_{OH} = − 0.5 mA	V_{DD} − 0.5	—	V_{DD}	V	DIO1, DIO2
	L Level	V_{OL}		I_{OL} = 0.5 mA	—	—	0.5		
Output Resis-tance	H Level	R_{OH}	—	$V_{OUT} = V_{DD}$ − 0.5 V (*3)	—	—	1.2	kΩ	O1 to O68
	M Level	R_{OM}		$V_{OUT} = V_1$ ± 0.5 V (*3)	—	—	1.2		
		R_{OM}		$V_{OUT} = V_4$ ± 0.5 V (*3)	—	—	1.2		
	L Level	R_{OL}		$V_{OUT} = V_5$ + 0.5 V (*3)	—	—	1.2		
Current Consumption		I_{SS}	—	V_{DD} = 5.5 V, V_5 = − 22.5 V, f_{FR} = 35.5 Hz, f_{LP} = 7.1 kHz, 01 to 068 : no load; Input Data : f_{DIO} = 71 Hz (Duty : 1/100), Input Voltage : H = V_{DD}, L = V_{SS} (*3)	—	2.0	4.0	μA	V_{SS}

(*2) : R_L = 3 kΩ, C_L = 1500 pF

(*3) : V_{DD} = 5.0 V, V_5 = − 7.8 V, $V_1 = V_{DD} - 1/9\,(V_{DD} - V_5)$, $V_4 = V_{DD} - 8/9\,(V_{DD} - V_5)$

AC CHARACTERISTICS



TEST CONDITIONS (V_{SS} = 0 V, V_{DD} = 4.5 to 5.5 V, V_5 = (V_{DD} − 23) V ± 10%, Ta = −20 to 75°C)

ITEM	SYMBOL	TEST CONDITION	MIN	MAX	UNIT
SCP Pulse Width H	t_{CWH}	LP	30	—	ns
SCP Pulse Width L	t_{CWL}	LP	1	—	μs
Input Rise / Fall Time	t_r, t_f	LP, FR, DIO1, DIO2	—	50	ns
Data Set-up Time	t_{DSU}	DIO1, DIO2	30	—	ns
Data Hold Time	t_{DHD}	DIO1, DIO2	50	—	ns
Output Data Delay Time A	tpdA	DIO1, DIO2 (*4)	80	—	ns
Output Data Delay Time B	tpdB	DIO1, DIO2 (*4)	—	1	μs

(*4) : C_L = 10 pF

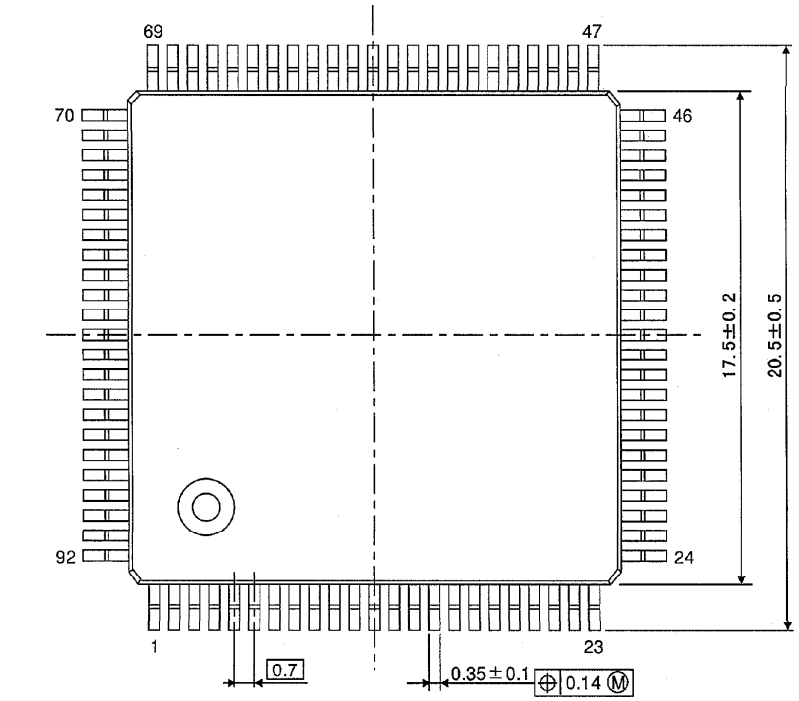
NOTE

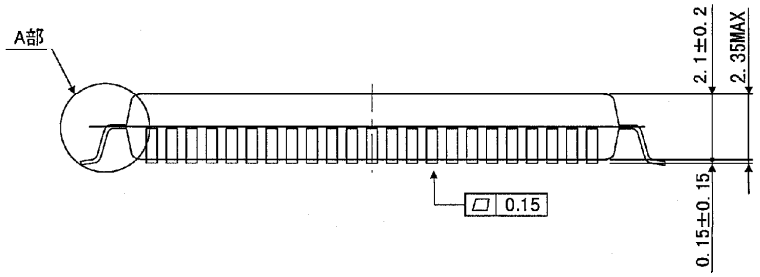
Insert the bypass capacitor (0.1 μF) between V_{DD} and V_{SS} to decrease power supply noise. Place the bypass capacitor as close to the LSI as possible.

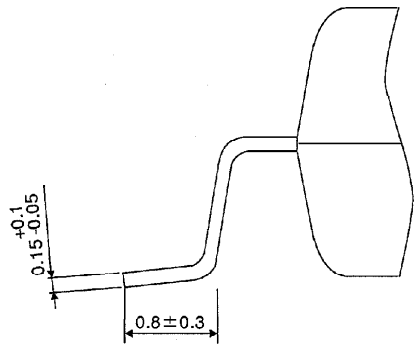
OUTLINE DRAWING

QFP92-P-1818-0.70B

Unit : mm



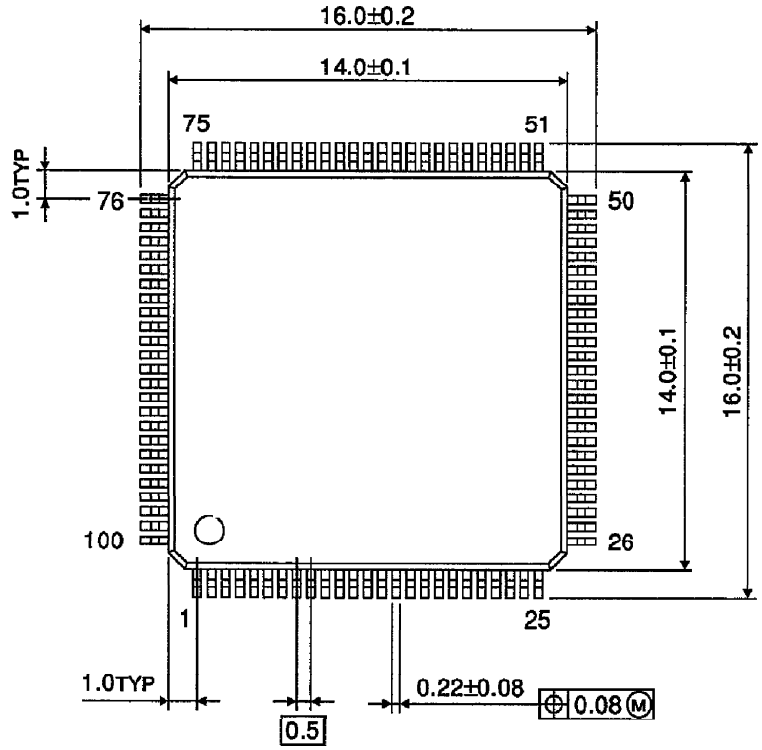


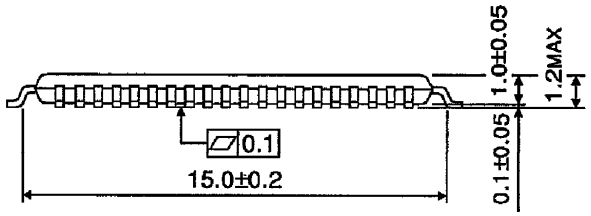


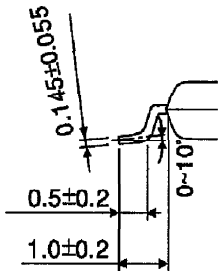
Weight : 1.45 g (Typ.)

OUTLINE DRAWING

TQFP100-P-1414-0.50 Unit : mm







Weight : 0.45 g (Typ.)